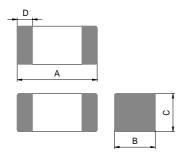
Ferrite Chip Bead(Lead Free)

FCM1005KF-102T03

1.Features

- 1. Monolithic inorganic material construction.
- 2.Closed magnetic circuit avoids crosstalk.
- 3.S.M.T. type.
- 4. Suitable for flow and reflow soldering.
- 5. Shapes and dimensions follow E.I.A. spec.
- 6. Available in various sizes.
- 7. Excellent solderability and heat resistance.
- 8. High reliability.
- 9. This component is compliant with RoHS legislation and also support lead-free soldering.

2.Dimensions



Chip Size						
A 1.00±0.10						
В	0.50±0.10					
С	0.50±0.10					
D	0.25±0.10					

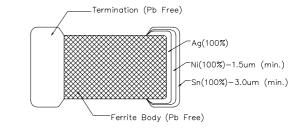
Units: mm

3.Part Numbering



E: Packaging T=Taping and Reel, B=Bulk(Bags)

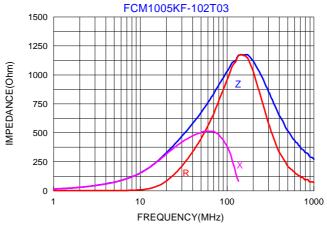
F: Rated Current 03=300m



4. Specification

Tai-Tech Part Number	Impedance ()	Test Frequency (Hz)	DC Resistance () max.	Rated Current (mA) max.
FCM1005KF-102T03	1000±25%	60mV/100M	1.20	300

■ Impedance-Frequency Characteristics



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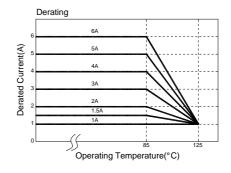
5. Reliability and Test Condition

Item					Perfor	mance	:				Test Condition
Series No.	FCB	FCM	НСВ	НРВ	HFB	FCA	FCI	FHI	FCH	HCI	
Operating Temperature		(Includ	-55~- ling self-t		ture rise)	(Includ		~+85 temperat	urerise)	
Storage Temperature			-55~	+125				-40	~+85		
Impedance (Z)											
Inductance (Ls)											HP4291A, HP4287A+16092A
Q Factor	Refe	r to stand	dard elec	trical ch	aracteris	tics list					
DC Resistance											HP4338B
Rated Current											**
Temperature Rise Test	30	max. (T)								Applied the allowed DC current. Temperature measured by digital surface thermometer. Preheat: 150 ,60sec. Solder: Sn-Ag3.0-Cu0.5 Solder tamperature: 260±5 Flux for lead free: rosin Dip time: 10±0.5sec.
Solder heat Resistance			lo signific ange: Witi		-			cal dama erminal e	ge. lectrode:7	7 0% min.	Preheating Dipping Natural cooling 260°C 150°C 60 10±0.5 second
Solderability		ode sho	% of the buld be			245°C	Preheating D	pping Natural			Preheat: 150 ,60sec. Solder: Sn-Ag3.0-Cu0.5 Solder tamperature: 245±5 Flux for lead free: rosin Dip time: 4±1sec.
Terminal strength	not be		electrode ed by the s.						→ \	W	For FCB FCM HCB HPB HFB FCI FHI FCH HCI: Size Force (Kgf)
Flexture strength	not be		electrode ed by the as.					45(1.772) 445(1.772) 146		Bending 40(1.575)	Solder a chip on a test substrate, bend the substrate by 2mm (0.079in)and return.
Bending Strength			ould not d on the			<u>R (</u>	0.5(0.0	1.0(0.03 2)	9)		Size mm(inches) P-Kgf 1608 0.80(0.033) 0.3 2012 1.40(0.055) 1.0 FCA3216 2.00(0.079) 1.5 3216 3.225 2.00(0.079) 2.5 4516 4532 2.70(0.106) 2.5 5750 2.70(0.106) 2.5
Random Vibration Test	chara	acteristic	Cracking s should vithin±30	not be a	-	ny othei	defects	harmful	to the		Frequency: 10-55-10Hz for 1 min. Amplitude: 1.52mm Directions and times: X, Y, Z directions for 2 hours. A period of 2 hours in each of 3 mutually perpendicular directions (Total 6 hours).

Item	Perfor	mance	Test Condition
Loading at High Temperature	Appearance: no damage.		Temperature: 125±5 (bead),85±5 (inductor) Applied current: rated current. Duration: 1008±12hrs. Measured at room temperature after placing for 2 to 3hrs.
Humidity	Inductance: within±10%of initial value. Q: within±30%of initial value. (FCI FHI Q: within±20%of initial value. (HCI)	Humidity: 90~95%RH. Temperature: 40±2 . Temperature: 60±2 .(HCI) Duration: 1008±12hrs. Measured at room temperature after placing for 2 to 3hrs.	
Thermal shock	Appearance: no damage. Impedance: within±30%of initial value. Inductance: within±10%of initial value. Q: within±30%of initial value. (FCI FHI FCH) Q: within±20%of initial value. (HCI)		For FCB FCM HCB HPB HFB FCA: Condition for 1 cycle Step1: -55±2 30±3 min. Step2: +125±5 30±3 min. Number of cycles: 5 For FCI FHI FCH HCI: Condition for 1 cycle Step1: -40±2 30±3 min. Step2: +85±5 30±3 min. Number of cycles: 100 Measured at room temperature after placing for 2 to 3 hrs.
Low temperature storage test		2 +85±5 30±3 Measured: 100 times	Temperature: -55±2 . Duration: 1008±12hrs. Measured at room temperature after placing for 2 to 3hrs.
Drop	a: No mechanical damage b: Impedance change: ±30%		Drop 10 times on a concrete floor from a height of 75cm

**Derating Curve

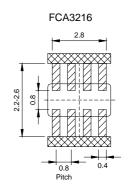
For the ferrite chip bead which withstanding current over 1.5A, as the operating temperature over 85 , the derating current information is necessary to consider with. For the detail derating of current, please refer to the Derated Current vs. Operating Temperature curve.



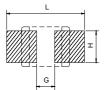
6. Soldering and Mounting

6-1. Recommended PC Board Pattern

			Pattern ow Sold	• • • •				
Series	Туре	A(mm)	B(mm)	C(mm)	D(mm)	L(mm)	G(mm)	H(mm)
FCB	1005	1.0±0.10	0.50±0.10	0.50±0.10	0.25±0.10	2.10	0.50	0.55
FCM	1608	1.6±0.15	0.80±0.15	0.80±0.15	0.30±0.20	2.60	0.60	0.80
HCB	2012	2.0±0.20	1.25±0.20	0.85±0.20	0.50±0.30	3.00	1.00	1.00
HPB	2012	2.0±0.20	1.25±0.20	1.25±0.20	0.50±0.30	3.00	1.00	1.00
HFB	2520	2.5±0.20	2.00±0.20	1.60±0.20	0.50±0.30	3.90	1.50	1.50
FCI	3216	3.2±0.20	1.60±0.20	1.10±0.20	0.50±0.30	4.40	2.20	1.40
FHI	3225	3.2±0.20	2.50±0.20	1.30±0.20	0.50±0.30	4.40	2.20	3.40
FCH	4516	4.5±0.20	1.60±0.20	1.60±0.20	0.50±0.30	5.70	2.70	1.40
HCI	4532	4.5±0.20	3.20±0.20	1.50±0.20	0.50±0.30	5.90	2.57	4.22
UHI	5750	5.7±0.20	5.00±0.30	1.80±0.20	0.50±0.30	8.00	4.00	5.80



Land
Solder Resist



PC board should be designed so that products are not sufficient under mechanical stress as warping the board.

Products shall be positioned in the sideway direction against the mechanical stress to prevent failure.

6-2. Soldering

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

6-2.1 Lead Free Solder re-flow:

Recommended temperature profiles for lead free re-flow soldering in Figure 1.

6-2.2 Solder Wave:

Wave soldering is perhaps the most rigorous of surface mount soldering processes due to the steep rise in temperature seen by the circuit when immersed in the molten solder wave , Due to the risk of thermal damage to products, wave soldering of large size products is discouraged. Recommended temperature profile for wave soldering is shown in Figure

6-2.3 Soldering Iron(Figure 3):

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

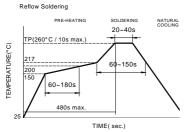
Note: Preheat circuit and products to 150

350 tip temperature for Ferrite chip bead (max)

Never contact the ceramic with the iron tip 1.0mm tip diameter (max)

Use a 20 watt soldering iron with tip diameter of 1.0mm

Limit soldering time to 3 sec.





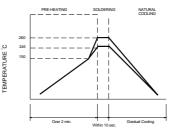


Figure 2. Wave Soldering

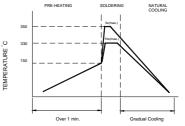
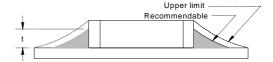


Figure 3. Hand Soldering

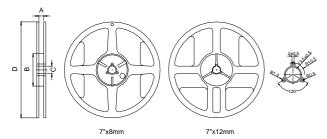
6-2.4 Solder Volume:

Accordingly increasing the solder volume, the mechanical stress to product is also increased. Exceeding solder volume may cause the failure of mechanical or electrical performance. Solder shall be used not to be exceed as shown in right side:



7. Packaging Information

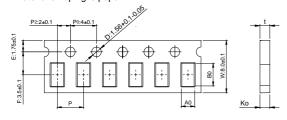
7-1. Reel Dimension



Туре	A(mm)	B(mm)	C(mm)	D(mm)
7"x8mm	9.0±0.5	60±2	13.5±0.5	178±2
7"x12mm	13.5±0.5	60±2	13.5±0.5	178±2

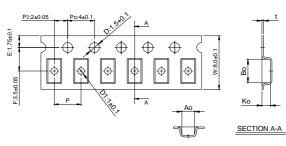
7-2.1 Tape Dimension / 8mm

Material of taping is paper



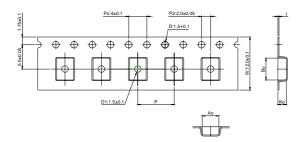
Series	Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
FCB.FCM.HCB	100505	1.12±0.03	0.62±0.03	0.60±0.03	2.0±0.10	0.60±0.03	none
HPB.HFB.FCI	160808	1.85±0.05	1.05±0.05	0.95±0.05	4.0±0.10	0.95±0.05	none
FHI.FCH.HCI	201209	2.30±0.05	1.50±0.05	0.95±0.05	4.0±0.10	0.95±0.05	none

Material of taping is plastic



Series	Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
FCB,FCM	160808	1.95±0.10	1.05±0.10	1.05±0.10	4.0±0.10	0.23±0.05	none
HCB,HPB	201209	2.25±0.10	1.42±0.10	1.04±0.10	4.0±0.10	0.22±0.05	1.0±0.10
HFB.FCI	201212	2.35±0.10	1.50±0.10	1.45±0.10	4.0±0.10	0.22±0.05	1.0±0.10
FHI.FCH	321611	3.50±0.10	1.88±0.10	1.27±0.10	4.0±0.10	0.22±0.05	1.0±0.10
HCI	322513	3.42±0.10	2.77±0.10	1.55±0.10	4.0±0.10	0.22±0.05	1.0±0.10
FCA	321609	3.40±0.10	1.77±0.10	1.04±0.10	4.0±0.10	0.22±0.05	1.0±0.10

7-2.2 Tape Dimension / 12mm

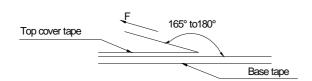


Series	Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
FCB,	451616	4.95±0.1	1.93±0.1	1.93±0.1	4.0±0.1	0.24±0.05	1.5±0.1
HCB.FCM	453215	4.95±0.1	3.66±0.1	1.85±0.1	8.0±0.1	0.24±0.05	1.5±0.1
FCI	575018	6.10±0.1	5.40±0.1	2.00±0.1	8.0±0.1	0.30±0.05	1.5±0.1

7-3. Packaging Quantity

Chip Size	575018	453215	451616	322513	321611	201212	201209	160808	100505
Chip / Reel	1000	1000	2000	2500	3000	2000	4000	4000	10000
Inner box	4000	4000	8000	12500	15000	10000	20000	20000	50000
Middle box	20000	20000	40000	62500	75000	50000	100000	100000	250000
Carton	40000	40000	80000	125000	150000	100000	200000	200000	500000
Bulk (Bags)	7000	12000	20000	30000	50000	100000	150000	200000	300000

7-4. Tearing Off Force



The force for tearing off cover tape is 15 to 60 grams in the arrow direction under the following conditions.

Room Temp.	Room Humidity	Room atm	Tearing Speed
()	(%)	(hPa)	mm/min
5~35	45~85	860~1060	300

Application Notice

Storage Conditions

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40 and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation

- 1.Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.